

Notice of References Cited	Application/Control No.	Applicant(s)/Patent Under Reexamination	
	10/613,494	LEE, JUN-YOUNG	
	Examiner	Art Unit	Page 1 of 1
Seokyun Moon	2675		

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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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